

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BEATY ET AL.	
		Examiner Sheela C Chawan	Art Unit 2526	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,859,924	01-1999	Liu et al.	382/145
	B	US-6,236,747	05-2001	King et al.	382/149
	C	US-6,118,540	09-2000	Roy et al.	356/394
	D	US-5,617,209	04-1997	Svetkoff et al.	356/608
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Shenghua Ye et al. " Vision -based system calibration for dimensional inspection " Nov 9, 1992, Pages 6.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.